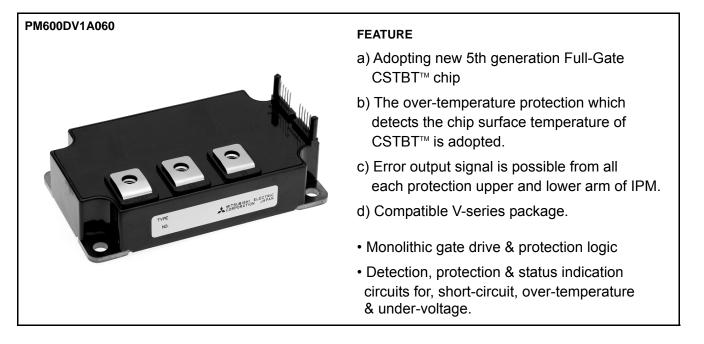
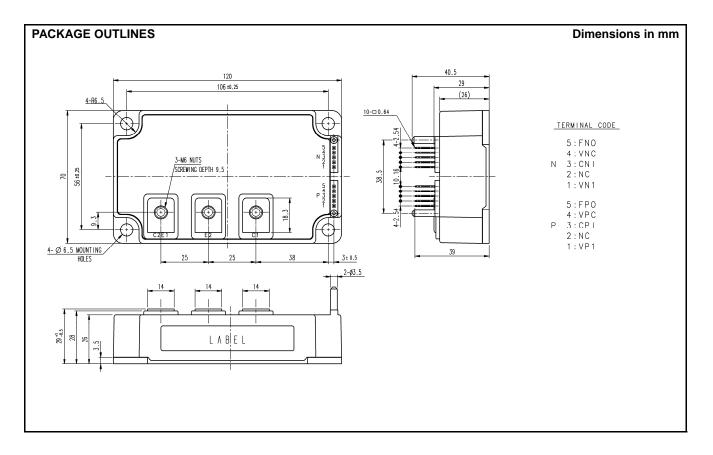
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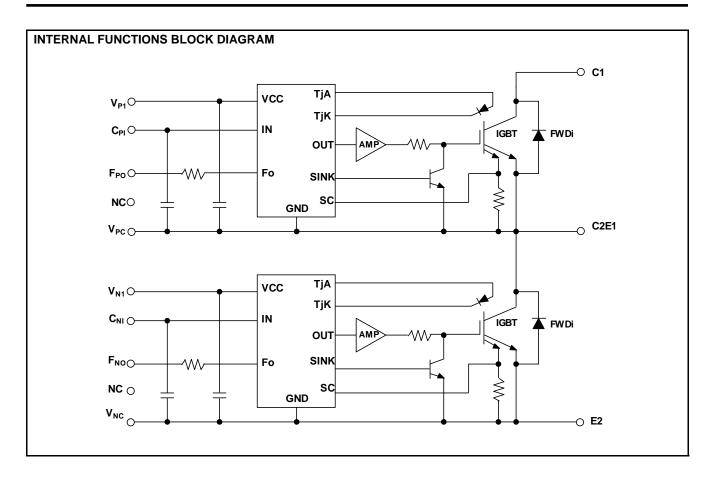
APPLICATION

General purpose inverter, servo drives and other motor controls



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MAXIMUM RATINGS ($T_j = 25^{\circ}C$, unless otherwise noted) **INVERTER PART**

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15V, V _{CIN} =15V	600	V
lc	Collector Current	T _C =25°C	600	А
I _{CRM}	Collector Current	Pulse	1200	
P _{tot}	Total Power Dissipation	T _C =25°C	1712	W
Ι _Ε	Emitter Current	T _C =25°C	600	А
I _{ERM}	(Free wheeling Diode Forward current)	Pulse	1200	~
Tj	Junction Temperature		-20 ~ +150	°C

*: Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
VD	Supply Voltage	Applied between : V _{P1} -V _{PC} , V _{N1} -V _{NC}	20	V
V _{CIN}	Input Voltage	Applied between : C_{PI} - V_{PC} , C_{NI} - V_{NC}	20	V
V _{FO}	Fault Output Supply Voltage	Applied between : FPO-VPC, FNO-VNC	20	V
I _{FO}	Fault Output Current	Sink current at F_{PO} , F_{NO} terminals	20	mA



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TOTAL SYSTEM

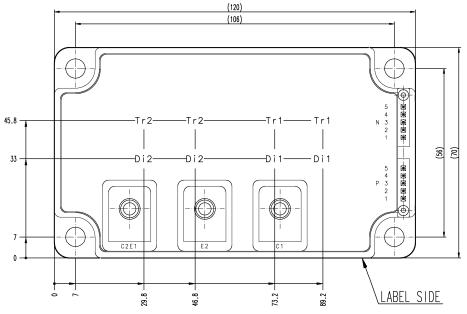
Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	$V_D = 13.5V \sim 16.5V$ Inverter Part, T _i =+125°C Start	400	V
V _{CC(surge)}	Supply Voltage (Surge)	Applied between : C1-E2, Surge value	500	V
Tc	Module case operating temperature		-20 ~ +100	°C
T _{stg}	Storage Temperature		-40 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

*: T_c measurement point is just under the chip.

THERMAL RESISTANCE

Symbol	Parameter	Conditions		Limits			Unit
Symbol	Farameter			Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal Resistance	Junction to case, IGBT (per 1 element)	(Note.1)	-	-	0.073	
R _{th(j-c)D}		Junction to case, FWDi (per 1 element)	(Note.1)	-	-	0.109	K/W
Б	Contact Thermal Resistance	Case to heat sink, (per 1 module)			0.010		
R _{th(c-s)}	Contact mermai Resistance	Thermal grease applied	(Note.1)	-	0.018	-	

Note1: If you use this value, $R_{th(s-a)}$ should be measured just under the chips.



ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise noted) **INVERTER PART**

Symbol	Parameter	Conditions		Limits			Unit	
Symbol	i diameter	Conditio	115		Min.	Тур.	Max.	Unit
V	Collector-Emitter Saturation	V _D =15V, I _C =600A		T _j =25°C	-	1.90	2.35	V
V _{CEsat}	Voltage	V _{CIN} =0V, Pulsed (Fig. 1)	oltage V _{CIN} =0V, Pulsed (Fig. 1) T _j =125°C	T _j =125°C	-	1.90	2.35	v
V _{EC}	Emitter-Collector Voltage	I _E =600A, V _D =15V, V _{CIN} = 15V		(Fig. 2)	-	1.7	2.8	V
t _{on}					0.3	0.8	2.0	
t _{rr}		$V_D=15V, V_{CIN}=0V \leftrightarrow 15V$			-	0.4	0.8	
t _{c(on)}	Switching Time	V _{cc} =300V, I _c =600A T _i =125°C			-	0.4	1.0	μs
t _{off}		Inductive Load (Fig. 3,4)	(Fig. 3.4)	-	1.0	2.3		
t _{c(off)}			(**9***,*)	-	0.3	1.0		
	Collector-Emitter Cut-off			T _j =25°C	-	-	1	m۸
I _{CES}	Current	$V_{CE}=V_{CES}, V_{D}=15V, V_{CIN}=15V$	(Fig. 5)	T _j =125°C	-	-	10	mA



FLAT-BASE TYPE INSULATED PACKAGE

CONTROL PART

Symbol	Parameter	Conditions			Limits		Unit
Symbol	Falameter			Min.	Тур.	Max.	Unit
I _D Circui	Circuit Current		V_{P1} - V_{PC}	-	2	4	mA
	Circuit Current	V _D =15V, V _{CIN} =15V	V _{N1} -V _{NC}	-	2	4	IIIA
V _{th(ON)}	Input ON Threshold Voltage	Applied between : C_{PI} - V_{PC} , C_{NI} - V_{NC}		1.2	1.5	1.8	v
$V_{\text{th(OFF)}}$	Input OFF Threshold Voltage			1.7	2.0	2.3	ľ
SC	Short Circuit Trip Level	-20≤Tj≤125°C, V _D =15V	(Fig. 3, 6)	900	-	-	Α
$t_{\text{off}(\text{SC})}$	Short Circuit Current Delay Time	V _D =15V	(Fig. 3, 6)	-	0.2	-	μS
OT	Over Temperature Dretection		Trip level	135	-	-	°C
OT _(hys)	Over Temperature Protection	Detect Temperature of IGBT chip	Hysteresis	-	20	-	
UVt	Supply Circuit Under-Voltage	20-7	Trip level	11.5	12.0	12.5	v
UVr	Protection	-20≤Tj≤125°C	Reset level	-	12.5	-	v
I _{FO(H)}	Fault Quitaut Quirant	out Current V _D =15V, V _{FO} =15V		-	-	0.01	
I _{FO(L)}	Fault Output Current		(Note.2)	-	10	15	mA
t _{FO}	Fault Output Pulse Width	V _D =15V	(Note.2)	1.0	1.8	-	ms

Note.2: Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

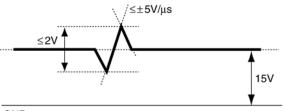
MECHANICAL RATINGS AND CHARACTERISTICS

Svmbol	Parameter	Conditions		Limits		
Symbol Farameter		Conditions		Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M6	3.92	4.90	5.88	N∙m
M _t		Main terminal part screw : M6	3.92	4.90	5.88	IN-III
m	Weight	-	-	510	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V _{cc}	Supply Voltage	Applied across C1-E2 terminals	≤ 400	V
V _D	Control Supply Voltage	Applied between : V_{P1} - V_{PC} , V_{N1} - V_{NC} (Note.3)	15.0±1.5	V
V _{CIN(ON)}	Input ON Voltage	Applied between : C _{PI} -V _{PC} , C _{NI} -V _{NC}	≤ 0.8	V
V _{CIN(OFF)}	Input OFF Voltage		≥ 4.0	v
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
\mathbf{t}_{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 3.0	μS

Note3: With ripple satisfying the following conditions: dv/dt swing $\leq \pm 5V/\mu$ s, Variation $\leq 2V$ peak to peak



GND



PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
 - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)

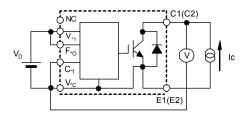


Fig. 1 V_{CEsat} Test

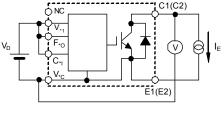


Fig. 2 V_{EC} Test

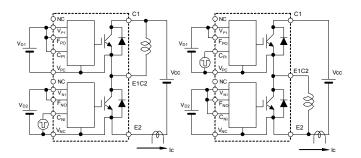


Fig. 3 Switching time and SC test circuit

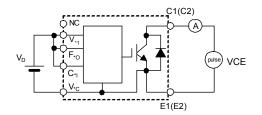


Fig. 5 I_{CES} Test

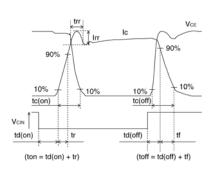


Fig. 4 Switching time test waveform

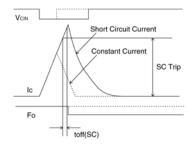
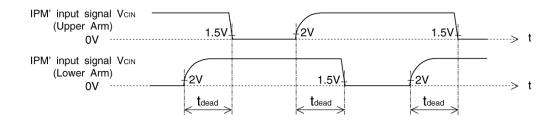


Fig. 6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example



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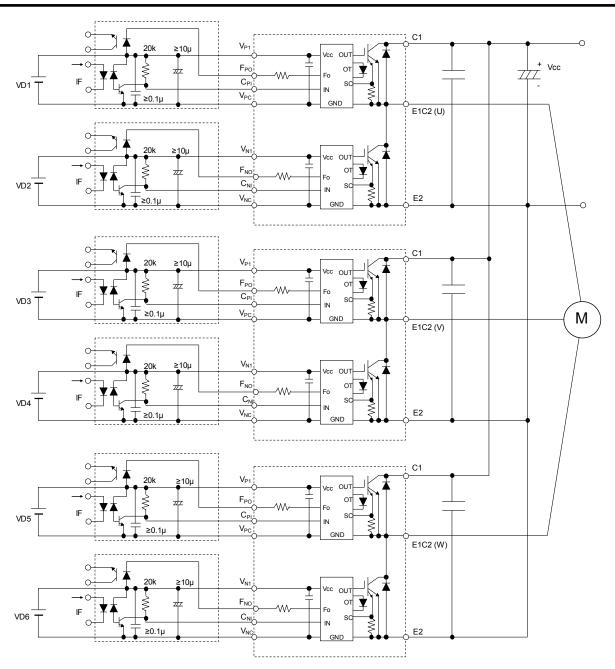


Fig. 8 Application Example Circuit

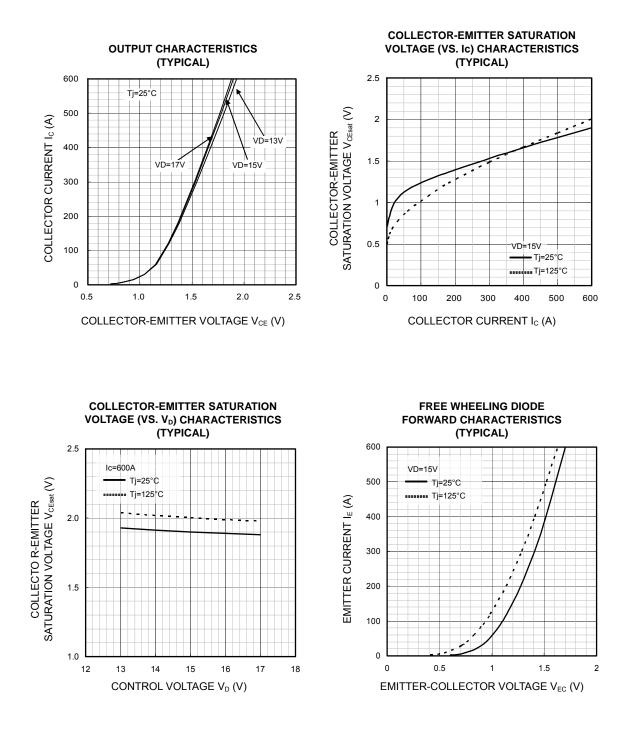
NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \le 0.8 \mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 6 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between C1 and E2 terminal.



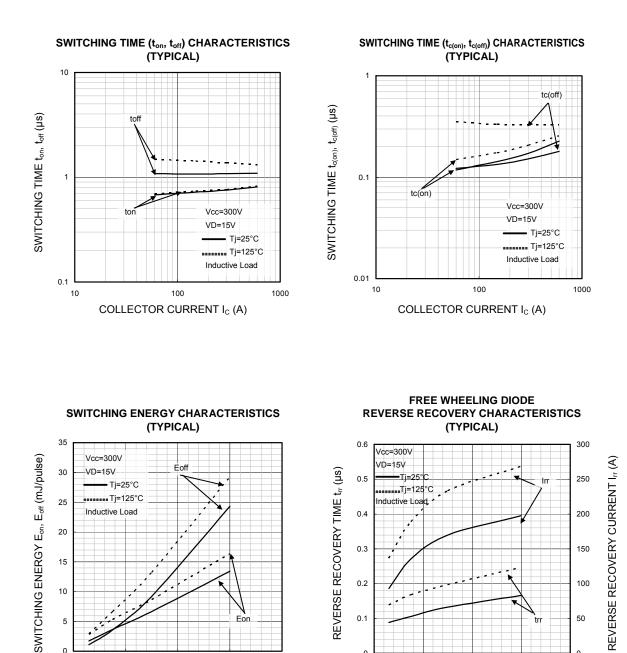
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PERFORMANCE CURVES





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0.2

0.1

Eor



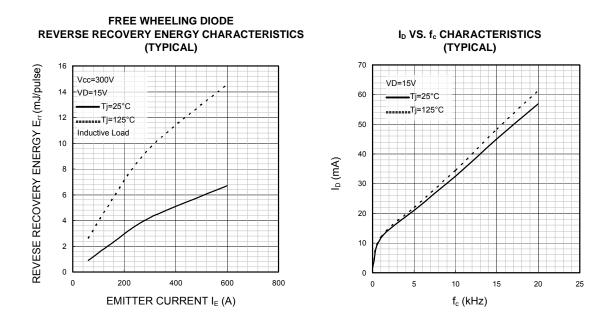
ECTRIC

COLLECTOR CURRENT I_C (A)

tri

EMITTER CURRENT IE (A)

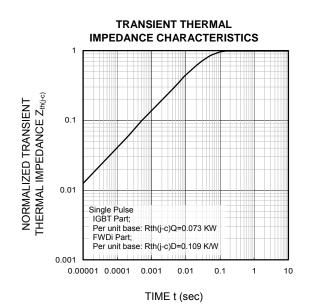
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UV TRIP LEVEL VS. T_i CHARACTERISTICS SC TRIP LEVEL VS. T_i CHARACTERISTICS (TYPICAL) (TYPICAL) 20 2 18 1.8 UVt VD=15V ••••••• UVr (SC of T_i=25°C is normalized 1) 16 1.6 14 1.4 1.2 12 UV_t/ UV_r (V) 10 SC 1 8 0.8 6 0.6 0.4 4 2 0.2 0 0 -50 0 50 100 150 -50 0 50 100 150 T_j (°C) T_j (°C)



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